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STD3PK50Z



P-channel 500 V, 3 Ωtyp., 2.8 A Zener-protected SuperMESHTM Power MOSFET in a DPAK package

Datasheet — production data

Features

Order code	V _{DSS}	R _{DS(on)} max	I _D	P _{TOT}
STD3PK50Z	500 V	< 4Ω	2.8 A	70 W

- Gate charge minimized
- Extremely high dv/dt capability
- 100% avalanche tested
- Very low intrinsic capacitance
- Improved ESD capability



■ Switching applications

Description

This device is a P-channel Zener-protected Power MOSFET developed using STMicroelectronics' SuperMESH™ technology, achieved through optimization of ST's well established strip-based PowerMESH™ layout. In addition to a significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

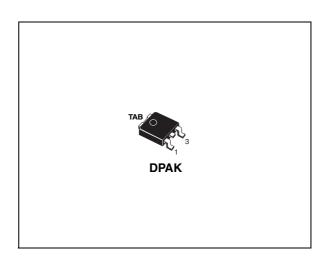


Figure 1. Internal schematic diagram

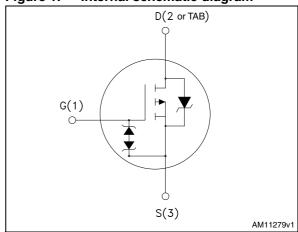


Table 1. Device summary

Order code	Marking	Package	Packaging
STD3PK50Z	3PK50Z	DPAK	Tape and reel

Note: For the P-channel Power MOSFETs actual polarity of voltages and current has to be reversed.

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STD3PK50Z Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain source voltage	500	V
V _{GS}	Gate- source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25 °C	2.8	Α
I _D	Drain current (continuous) at T _C = 100 °C	1.8	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	11	Α
P _{TOT}	Total dissipation at T _C = 25 °C	85	W
I _{AR}	Max current during repetitive or single pulse avalanche (pulse width limited by T _{jmax})	2.8	Α
E _{AS}	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AS}$, $V_{DD} = 50$ V)	200	mJ
dv/dt (2)	Peak diode recovery voltage slope	40	V/ns
ESD Gate-source human body model (R = 1,5 k, C = 100 pF)		3	kV
T _j T _{stg}	Operating junction temperature Storage temperature	- 55 to 150	°C

^{1.} Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol Parameter		Value	Unit
Rthj-case	Thermal resistance junction-case max	1.47	°C/W
Rthj-pcb	Thermal resistance junction-pcb max	50	°C/W

Note: For the P-channel Power MOSFETs actual polarity of voltages and current has to be reversed.

^{2.} $I_{SD} \le 2.8 \text{ A}, \text{ di/dt } \le 200 \text{ A/µs}, V_{Peak} \le V_{(BR)DSS}$

Electrical characteristics STD3PK50Z

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions		Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	500			٧
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 500 V, V _{DS} = 500 V,Tc=125 °C			1 100	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	3.75	4.5	٧
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 1.4 A		3	4	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance			530		pF
C _{oss}	Output capacitance	V _{DS} =50 V, f=1 MHz, V _{GS} =0	-	50	-	pF
C _{rss}	Reverse transfer capacitance	105 00 i, iiii <u>-</u> , igs 0		25		pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V 0 V 0 to 400 V	-	32	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0$, $V_{DS} = 0$ to 400 V	-	23	-	pF
R _G	Intrinsic gate resistance	f = 1MHz open drain	-	4.7	-	Ω
Qg	Total gate charge	$V_{DD} = 400 \text{ V}, I_{D} = 2.8 \text{ A}$		29		nC
Q_{gs}	Gate-source charge	V _{GS} =10 V	-	4.3	-	nC
Q_{gd}	Gate-drain charge	(see Figure 14)		15		nC

^{1.} Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Note: For the P-channel Power MOSFETs actual polarity of voltages and current has to be reversed.

^{2.} energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 250 V, I_{D} = 1.4 A, R_{G} =4.7 Ω V_{GS} =10 V (see Figure 13)	-	16 15 46 26	-	ns ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)		-		2.8 11.2	mA A
V _{SD} ⁽¹⁾	Forward on voltage	I _{SD} = 2.8 A, V _{GS} =0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 2.8 A, V_{DD} = 60 V di/dt = 100 A/µs, (see Figure 15)	-	220 1600 14		ns nC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 2.8 A,V _{DD} = 60 V di/dt=100 A/μs, Tj=150 °C (see Figure 15)) V			ns nC A

^{1.} Pulsed: pulse duration = 300µs, duty cycle 1.5%

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
BV_{GSO}	Gate-source breakdown voltage	Igs ± 1mA, (open drain)	30		-	V	

The built-in back- to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

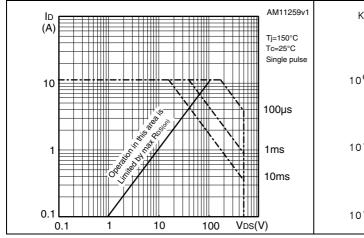
Note: For the P-channel Power MOSFETs actual polarity of voltages and current has to be reversed.

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2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

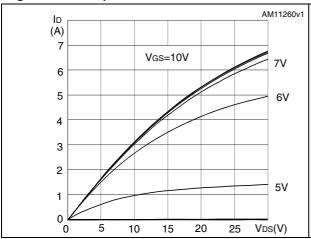


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10⁰ $\delta = 0.5$ 10⁻¹ 0.2 0.05 0.01 0.

Figure 4. Output characteristics

Figure 5. Transfer characteristics



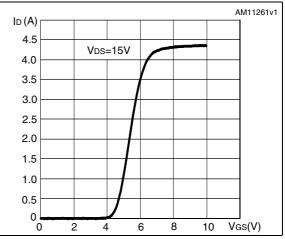
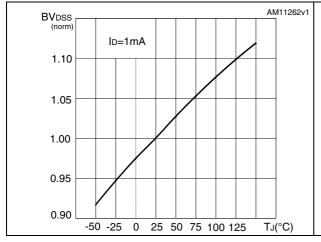
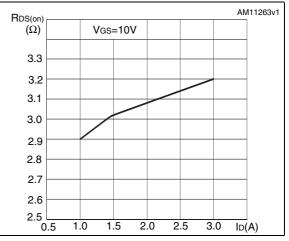


Figure 6. Normalized B_{VDSS} vs temperature

Figure 7. Static drain-source on-resistance





AM11264v1 AM11265v1 C (pF) Vgs VDS(V) VDD=400V (V) VDS ID=2.8A 400 12 350 1000 Ciss 10 300 8 250 100 200 6 150 Coss 4 Crss 100 2 50 0 20 25 30 5 10 15 Q_g(nC) 100 V_{DS}(V) 0.1 10

Figure 8. Gate charge vs gate-source voltage Figure 9. **Capacitance variations**

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on-resistance vs vs temperature

temperature

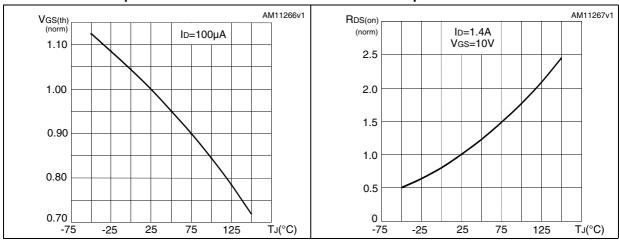
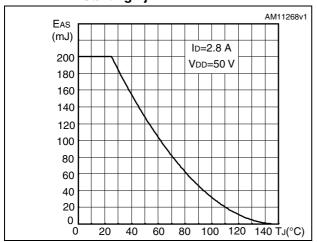


Figure 12. Maximum avalanche energy vs starting Tj



Test circuits STD3PK50Z

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

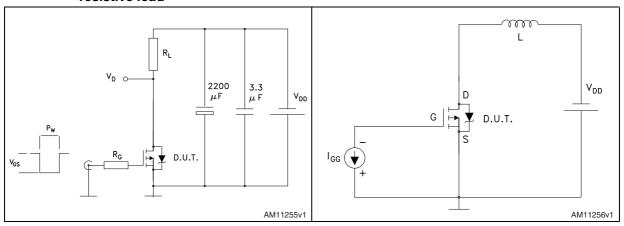
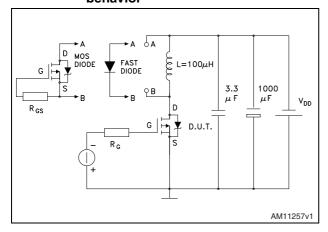


Figure 15. Test circuit for diode recovery behavior



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK $^{\otimes}$ packages, depending on their level of environmental compliance. ECOPACK $^{\otimes}$ specifications, grade definitions and product status are available at: www.st.com. ECOPACK $^{\otimes}$ is an ST trademark.

Table 9. DPAK (TO-252) mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
Е	6.40		6.60
E1		4.70	
е		2.28	
e1	4.40		4.60
Н	9.35		10.10
L	1		1.50
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0°		8°

Figure 16. DPAK (TO-252) drawing

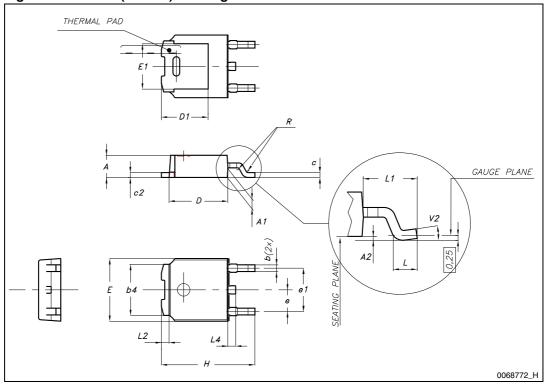
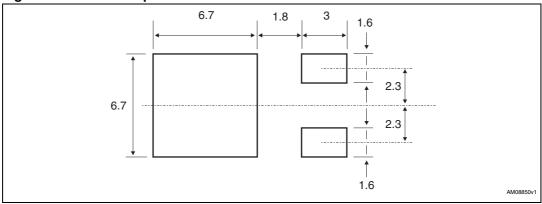


Figure 17. DPAK footprint^(a)



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a. All dimensions are in millimeters

5 Packaging mechanical data

Table 10. DPAK (TO-252) tape and reel mechanical data

Tubic I	Таре	z) tape and reer		Reel	
Di	m	mm		m	ım
Dim.	Min.	Max.	Dim.	Min.	Max.
A0	6.8	7	А		330
В0	10.4	10.6	В	1.5	
B1		12.1	С	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
Е	1.65	1.85	N	50	
F	7.4	7.6	Т		22.4
K0	2.55	2.75			
P0	3.9	4.1		Base qty.	2500
P1	7.9	8.1		Bulk qty.	2500
P2	1.9	2.1			•
R	40				
Т	0.25	0.35			
W	15.7	16.3			

Figure 18. Tape for DPAK (TO-252)

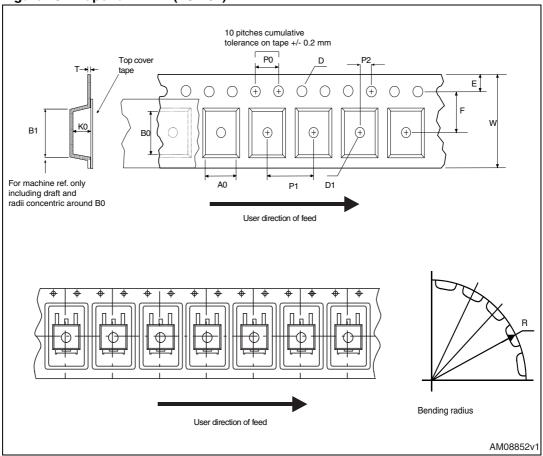
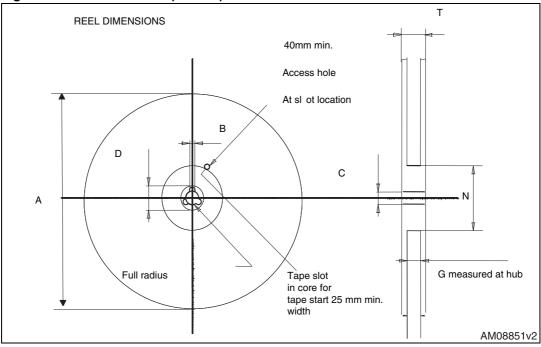


Figure 19. Reel for DPAK (TO-252)



Revision history STD3PK50Z

6 Revision history

Table 11. Document revision history

Date	Revision	Changes
26-Nov-2010	1	First release.
31-Aug-2012	2	Document status promoted from preliminary data to production data. Minor text changes on the cover page.

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